

General Description

This planar stripe MOSFET has better characteristics, such as fast switching time, low on resistance, low gate charge and excellent avalanche characteristics. It is mainly suitable for electronic ballast and switching mode power supplies.

FEATURES

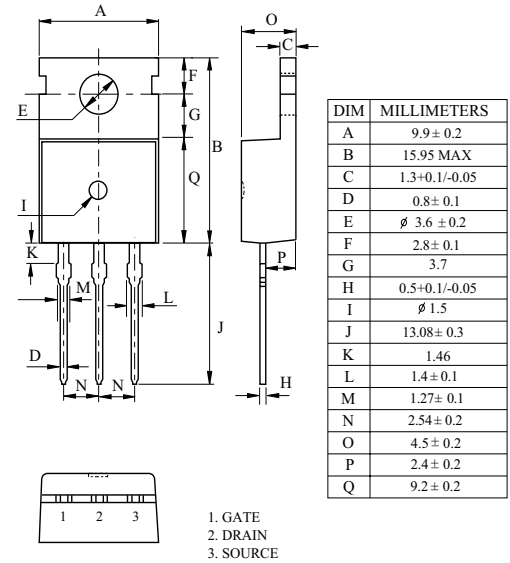
- $V_{DSS(Min.)} = 500V$, $I_D = 9A$
- Drain-Source ON Resistance :
 $R_{DS(ON)} = 0.8 \Omega$ @ $V_{GS} = 10V$
- $Q_g(yp.) = 34.6nC$

MAXIMUM RATING (Tc=25℃)

CHARACTERISTIC		SYMBOL	RATING		UNIT
			KHB9D0N50P1	KHB9D0N50F1	
Drain-Source Voltage		V _{DSS}	500		V
Gate-Source Voltage		V _{GSS}	±30		V
Drain Current	@T _C =25 ℃	I _D	9	9*	A
	@T _C =100 ℃		5.4	5.4*	
	Pulsed (Note1)	I _{DP}	36	36*	
Single Pulsed Avalanche Energy (Note 2)		E _{AS}	360		mJ
Repetitive Avalanche Energy (Note 1)		E _{AR}	13.5		mJ
Peak Diode Recovery dv/dt (Note 3)		dv/dt	4.5		V/ns
Drain Power Dissipation	Tc=25 ℃	P _D	135	44	W
	Derate above25 ℃		1.07	0.35	W/ ℃
Maximum Junction Temperature		T _j	150		℃
Storage Temperature Range		T _{stg}	-55～150		℃
Thermal Characteristics					
Thermal Resistance, Junction-to-Case		R _{thJC}	0.93	2.86	℃/W
Thermal Resistance, Case-to-Sink		R _{thCS}	0.5	-	℃/W
Thermal Resistance, Junction-to-Ambient		R _{thJA}	62.5	62.5	℃/W

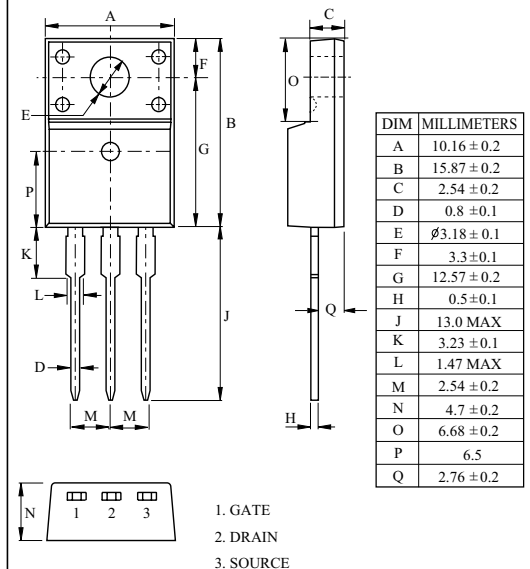
* : Drain current limited by maximum junction temperature.

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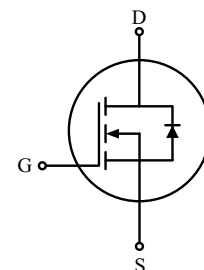


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ELECTRICAL CHARACTERISTICS (Tc=25 °C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	BV _{DSS}	I _D =250μA, V _{GS} =0V	500	-	-	V
Breakdown Voltage Temperature Coefficient	ΔBV _{DSS} / ΔT _j	I _D =250μA, Referenced to 25 °C	-	0.57	-	V/°C
Drain Cut-off Current	I _{DSS}	V _{DS} =500V, V _{GS} =0V,	-	-	10	μA
Gate Threshold Voltage	V _{th}	V _{DS} =V _{GS} , I _D =250 μA	2.0	-	4.0	V
Gate Leakage Current	I _{GSS}	V _{GS} =±30V, V _{DS} =0V	-	-	±100	nA
Drain-Source ON Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =4.5A	-	0.65	0.8	Ω
Dynamic						
Total Gate Charge	Q _g	V _{DS} =400V, I _D =9A V _{GS} =10V (Note4,5)	-	34.6	40	nC
Gate-Source Charge	Q _{gs}		-	5.9	-	
Gate-Drain Charge	Q _{gd}		-	15.5	-	
Turn-on Delay time	t _{d(on)}	V _{DD} =200V R _L =22 Ω R _G =25 Ω (Note4,5)	-	23	45	ns
Turn-on Rise time	t _r		-	65	140	
Turn-off Delay time	t _{d(off)}		-	148	241	
Turn-off Fall time	t _f		-	81	140	
Input Capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1.0MHz	-	1389	1805	pF
Reverse Transfer Capacitance	C _{rss}		-	19.2	24.9	
Output Capacitance	C _{oss}		-	155.7	202	
Source-Drain Diode Ratings						
Continuous Source Current	I _S	V _{GS} <V _{th}	-	-	9	A
Pulsed Source Current	I _{SP}		-	-	36	
Diode Forward Voltage	V _{SD}	I _S =9A, V _{GS} =0V	-	-	1.5	V
Reverse Recovery Time	t _{rr}	I _S =9A, V _{GS} =0V,	-	357	-	ns
Reverse Recovery Charge	Q _{rr}	dI _S /dt=100A/μs	-	4.87	-	μC

Note 1) Repetivity rating : Pulse width limited by junction temperature.

Note 2) $L = 8mH$, $I_S=9A$, $V_{DD}=50V$, $R_G = 25\Omega$, Starting $T_j = 25\text{ }^\circ\text{C}$.

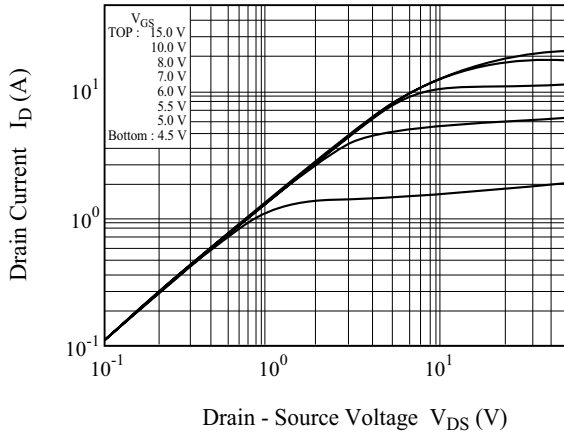
Note 3) $I_S \leq 9A$, $dI/dt \leq 200A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting $T_j = 25\text{ }^\circ\text{C}$.

Note 4) Pulse Test : Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.

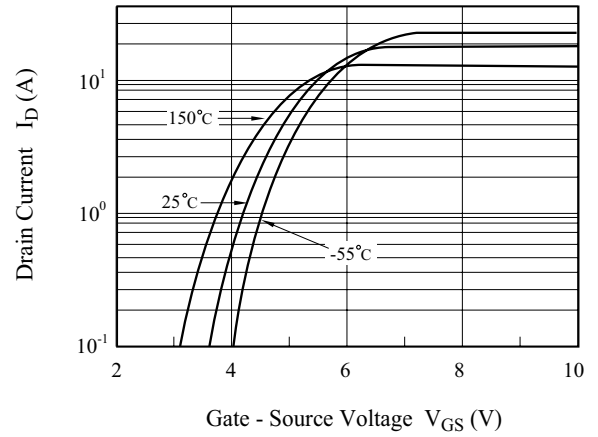
Note 5) Essentially independent of operating temperature.

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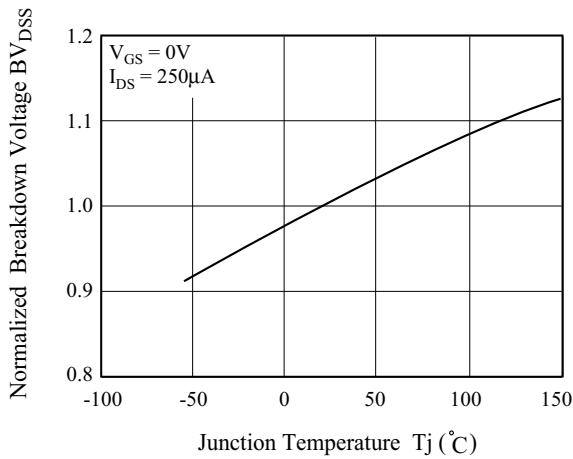
$I_D - V_{DS}$



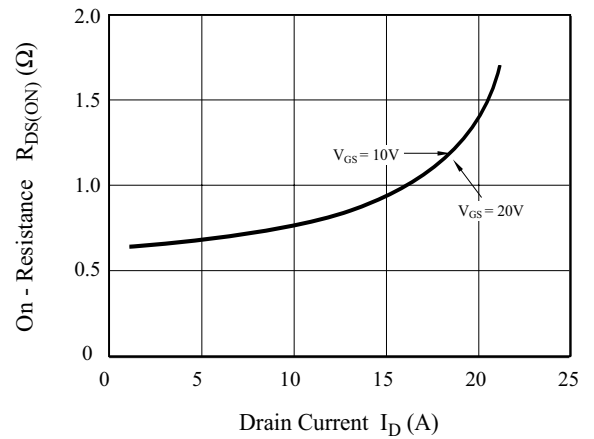
$I_D - V_{GS}$



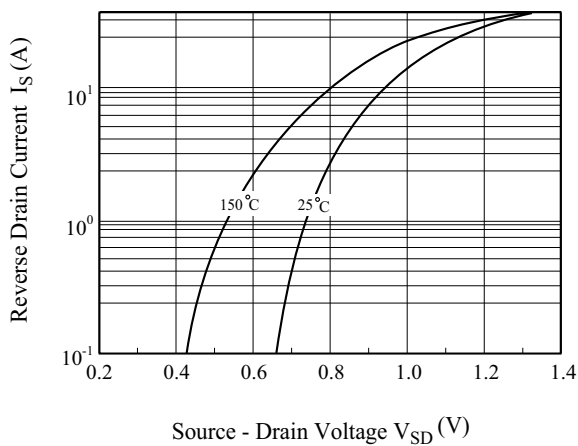
$BV_{DSS} - T_j$



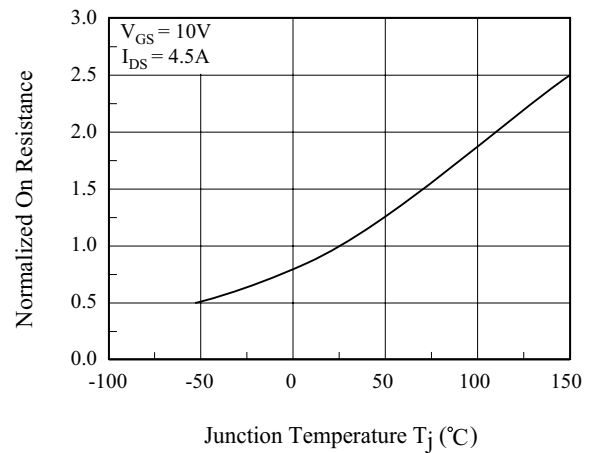
$R_{DS(ON)} - I_D$



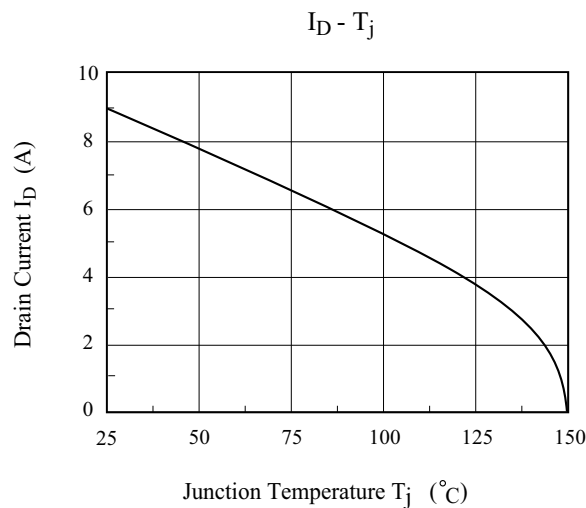
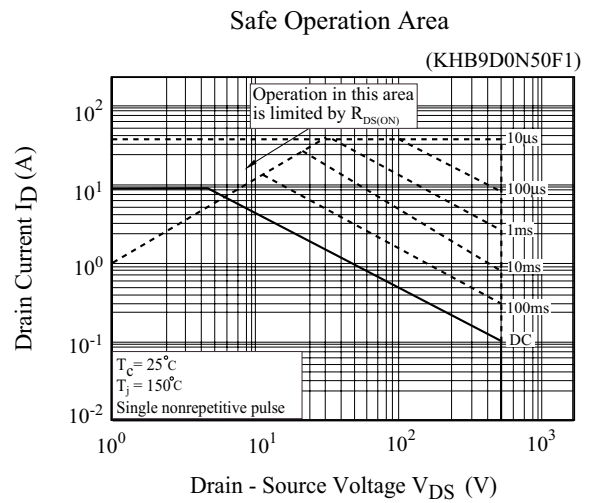
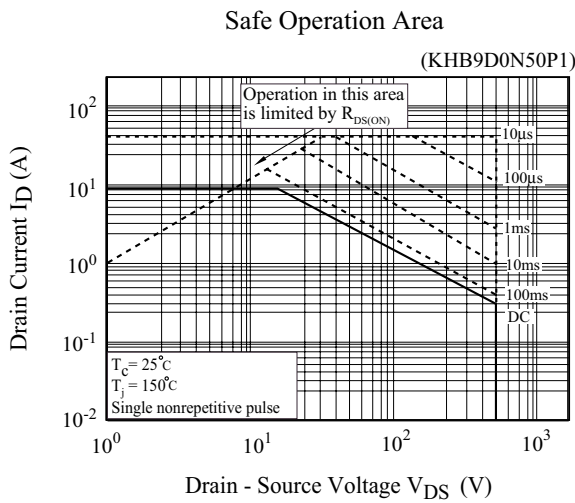
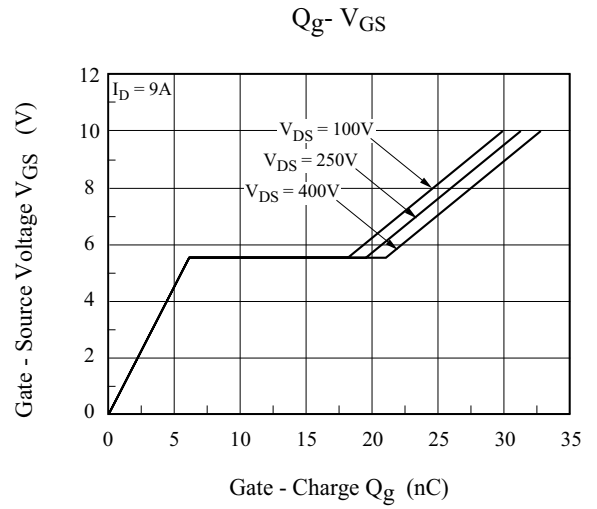
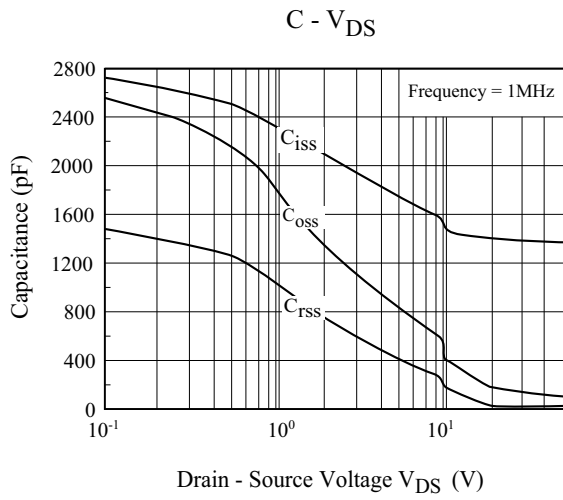
$I_S - V_{SD}$



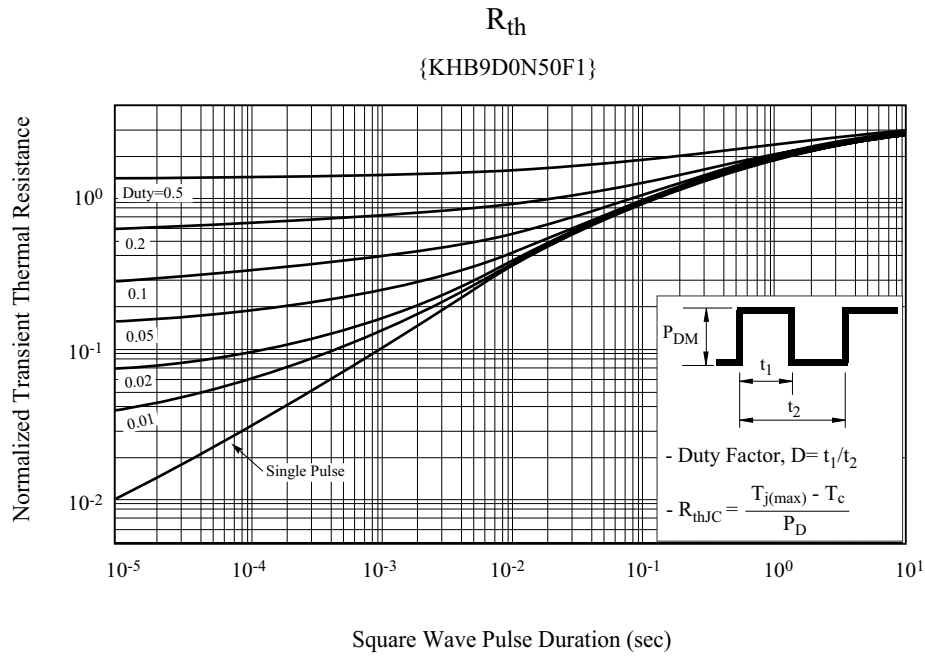
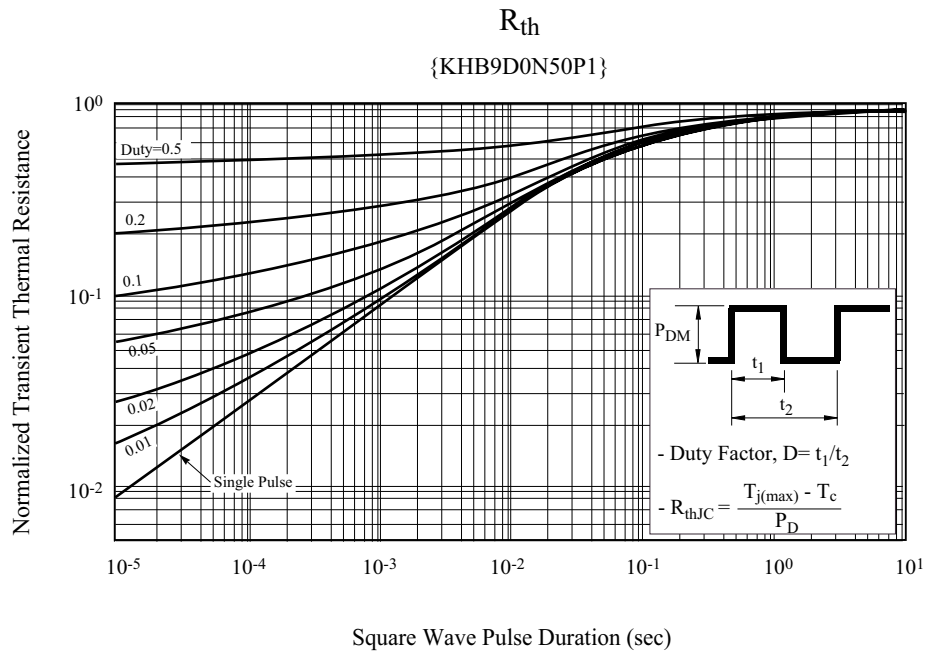
$R_{DS(ON)} - T_j$



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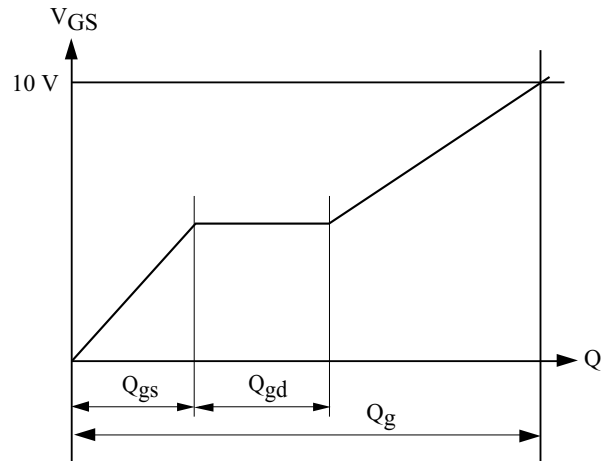
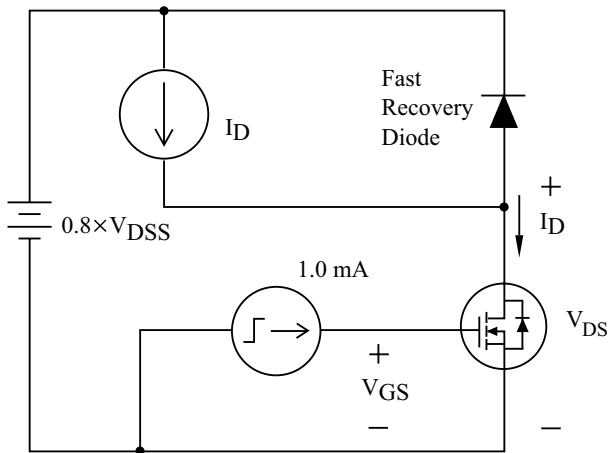


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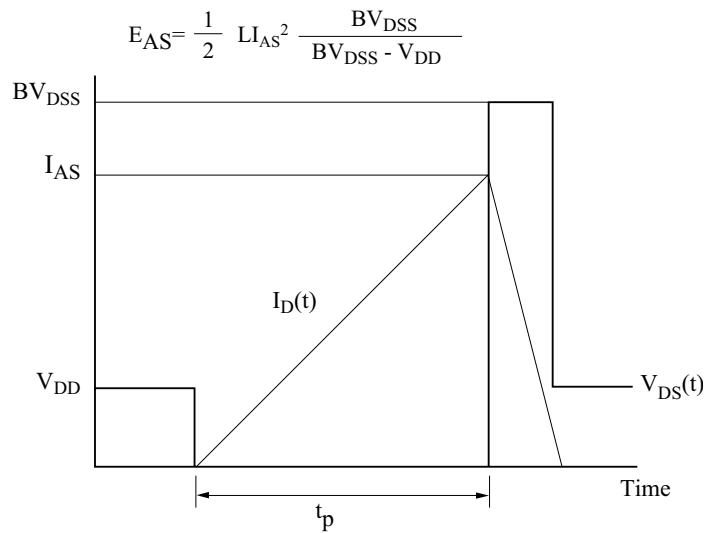
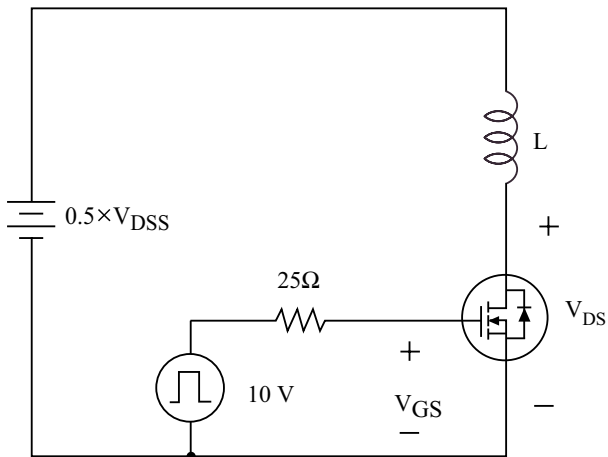


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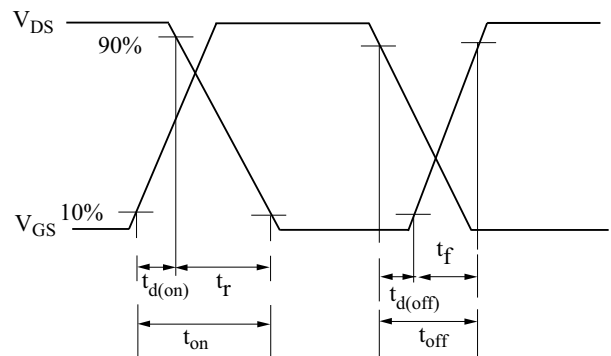
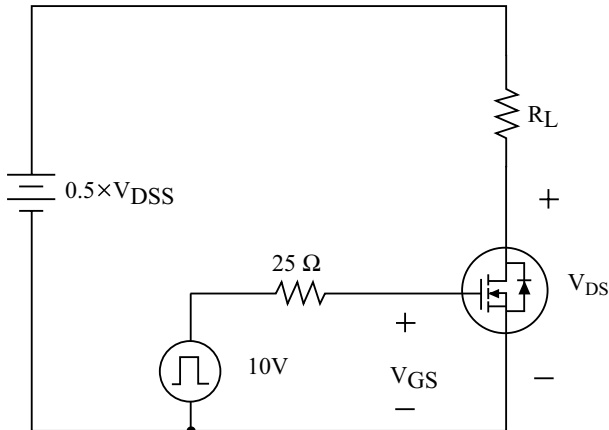
- Gate Charge



- Single Pulsed Avalanche Energy



- Resistive Load Switching



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- Source - Drain Diode Reverse Recovery and dv/dt

